



### DESCRIPTION

The AM75R540 is available in TO-220, TO-220F and TO-252 packages.

V <sub>DS</sub>	R <sub>DS(ON)</sub>	I <sub>D</sub>
750V	0.54 Ω	8A

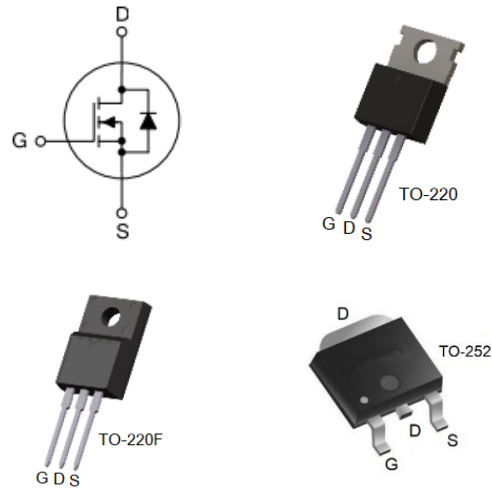
### FEATURE

- Best-in-class FOM R<sub>DS(ON)</sub> \*E<sub>oss</sub>; reduced Q<sub>g</sub>, C<sub>iss</sub>, and C<sub>oss</sub>
- Fast Switching
- 100% avalanche tested
- Improved dv/dt capability

### PIN DESCRIPTION

Application:

- High-frequency switching mode power supply
- Flyback topologies for LED Lighting, low power Chargers and Adapters.



### ORDERING INFORMATION

Package Type	Part Number	
TO-220 SPQ: 50pcs/Tube	T3	AM75R540T3VU
TO-220F SPQ: 50pcs/Tube	T3F	AM75R540T3FVU
TO-252 SPQ: 2,500pcs/Reel	D	AM75R540DVR
Note	V: Halogen Free Package U: Tube R: Tape & Reel	
AiT provides all RoHS products		

Pin#		Symbol	Function
TO-220 TO-220F	TO-252		
1	1	G	Gate
2	2,4	D	Drain
3	3	S	Source

**ABSOLUTE MAXIMUM RATINGS**

T<sub>C</sub> = 25°C, unless otherwise specified.

V <sub>DS</sub> , Drain-to-Source Voltage		700V
I <sub>D</sub> , Continuous Drain Current		8A
I <sub>D</sub> , Continuous Drain Current T <sub>C</sub> = 100 °C		5A
I <sub>DM</sub> , Pulsed Drain Current <sup>(1)</sup>		24A
V <sub>GS</sub> , Gate-to-Source Voltage		±30V
E <sub>AS</sub> , Single Pulse Avalanche Energy <sup>(2)</sup>		145mJ
dv/dt, Peak Diode Recovery dv/dt <sup>(3)</sup>		15V/ns
P <sub>D</sub> , Power Dissipation	TO-220, TO-252	90W
	TO-220F	28W
P <sub>D</sub> , Derating Factor above 25°C	TO-220, TO-252	0.73W/°C
	TO-220F	0.22W/°C
T <sub>J</sub> , Operating Junction Temperature Range		150°C
T <sub>STG</sub> , Storage Temperature Range		-55°C~+150°C
T <sub>L</sub> , Maximum Temperature for Soldering		300°C
R <sub>θJA</sub> , Junction-to-Ambient	TO-220, TO-252	62.5°C/W
	TO-220F	80°C/W
R <sub>θJC</sub> , Junction-to-Case	TO-220, TO-252	1.39°C/W
	TO-220F	4.6°C/W

Stresses above may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated in the Electrical Characteristics are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

(1) Pulse width limited by maximum junction temperature

(2) L=20mH, V<sub>DS</sub>=50V, Start T<sub>J</sub>=25°C

(3) I<sub>SD</sub> =3A, di/dt ≤100A/us, V<sub>DD</sub>≤B<sub>VDS</sub>, Start T<sub>J</sub>=25°C



**ELECTRICAL CHARACTERISTICS**

T<sub>c</sub> = 25°C, unless otherwise specified.

Parameter	Symbol	Conditions	Min	Typ.	Max	Unit
<b>OFF Characteristics</b>						
Drain to Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	700	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\frac{\Delta V_{DS}}{\Delta T_J}$	I <sub>D</sub> =250μA Reference 25°C	-	0.7	-	V/°C
Drain to Source Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> =700V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C	-	-	1	μA
		V <sub>DS</sub> =560V, V <sub>GS</sub> =0V, T <sub>J</sub> =125°C	-	-	10	
Gate to Source Forward Leakage	I <sub>GSS(F)</sub>	V <sub>GS</sub> =+30V	-	-	100	nA
Gate to Source Reverse Leakage	I <sub>GSS(R)</sub>	V <sub>GS</sub> =-30V	-	-	-100	nA
<b>ON Characteristics</b>						
Drain-to-Source On-Resistance	R <sub>DSON</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =2.1A <sup>(4)</sup>	-	0.54	0.6	Ω
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> =250μA <sup>(4)</sup>	3.0	-	4.0	V
<b>Dynamic Characteristics</b>						
Gate resistance	R <sub>g</sub>	f=1.0MHz	-	8.5	-	Ω
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V, f=1.0MHz	-	490	-	pF
Output Capacitance	C <sub>oss</sub>		-	530	-	
Reverse Transfer Capacitance	C <sub>rss</sub>		-	12	-	
<b>Switching Characteristics</b>						
Turn-on Delay Time	t <sub>d(ON)</sub>	I <sub>D</sub> =3A, V <sub>DD</sub> =400V, V <sub>GS</sub> =10V, R <sub>G</sub> =10Ω	-	10	-	ns
Rise Time	t <sub>r</sub>		-	7	-	
Turn-Off Delay Time	t <sub>d(OFF)</sub>		-	41	-	
Fall Time	t <sub>f</sub>		-	28	-	
Total Gate Charge	Q <sub>g</sub>	I <sub>D</sub> =3A, V <sub>DD</sub> =480V, V <sub>GS</sub> =10V	-	16	-	nC
Gate to Source Charge	Q <sub>gs</sub>		-	2.5	-	
Gate to Drain ("Miller") Charge	Q <sub>gd</sub>		-	5.6	-	
<b>Source-Drain Diode Characteristics</b>						
Continuous Source Current (Body Diode)	I <sub>S</sub>	T <sub>c</sub> =25°C	-	-	8	A
Maximum Pulsed Current (Body Diode)	I <sub>SM</sub>		-	-	24	A
Diode Forward Voltage	V <sub>SD</sub>	I <sub>S</sub> =3A, V <sub>GS</sub> =0V*	-	-	1.2	V
Reverse Recovery Time	T <sub>rr</sub>	I <sub>S</sub> =3A, T <sub>J</sub> =25°C dIF/dt =100A/μs V <sub>GS</sub> =0V	-	196	-	ns
Reverse Recovery Charge	Q <sub>rr</sub>		-	1568	-	nC
Reverse Recovery Current	I <sub>rrm</sub>		-	16	-	A

\* Pulse width tp≤300μs, δ≤2%



**TYPICAL PERFORMANCE CHARACTERISTICS**

Fig 1. Safe Operating Area (TO-220)

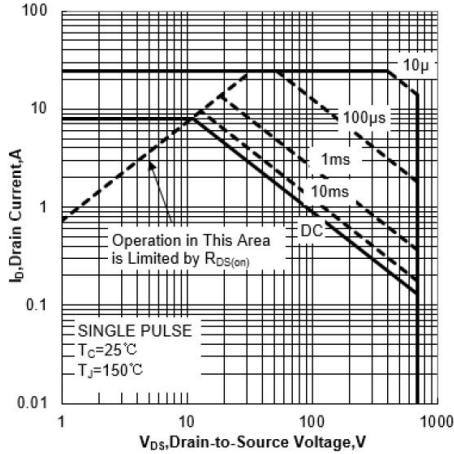


Fig 2. Safe Operating Area (TO-220F)

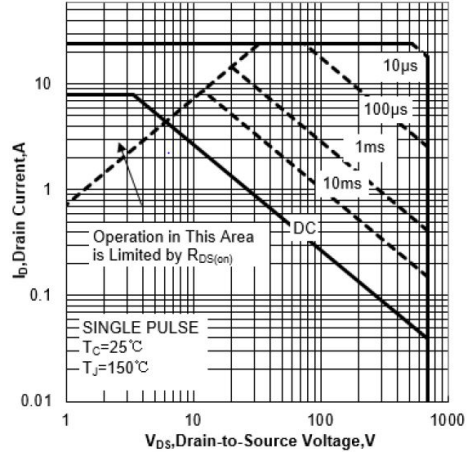


Fig3. Power Dissipation (TO-220)

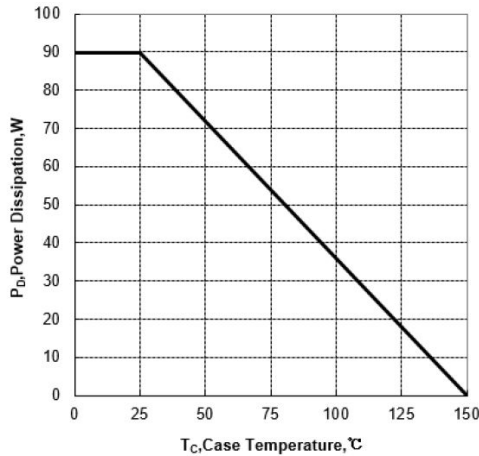


Fig4. Power Dissipation (TO-220F)

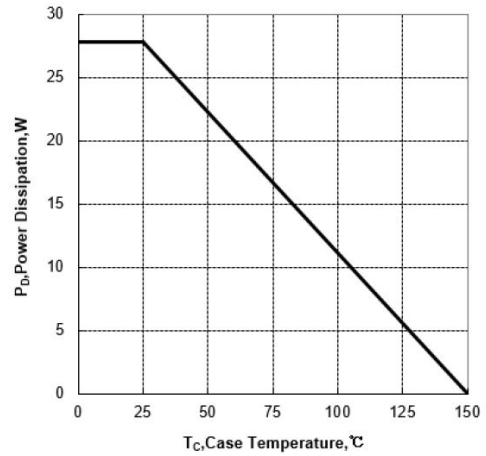


Fig5. Max Thermal Impedance (TO-220)

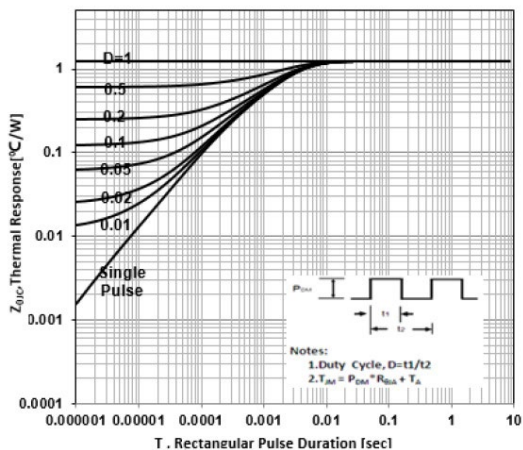


Fig6. Max Thermal Impedance (TO-220F)

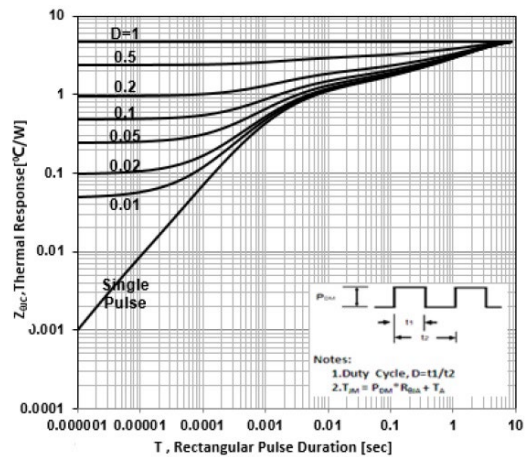




Fig7. Typical Output Characteristics

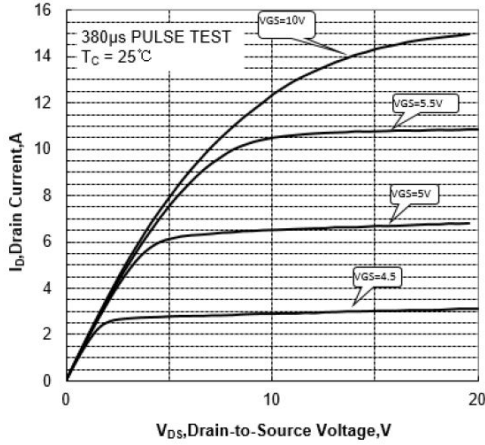


Fig8. Typical Transfer Characteristics

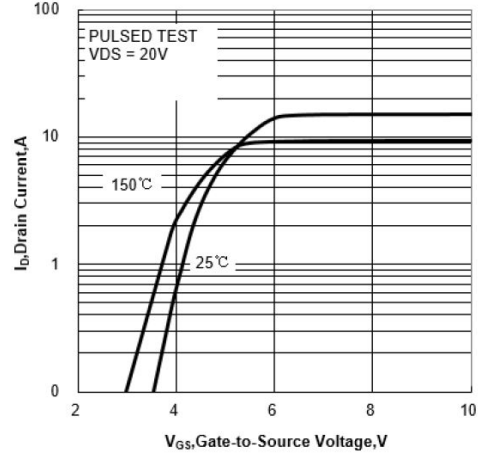


Fig9. Typical Drain to Source ON Resistance vs. Drain Current

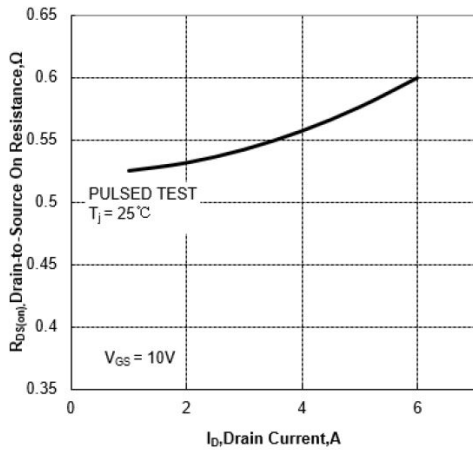


Fig10. Typical Drain to Source on Resistance vs. Junction Temperature

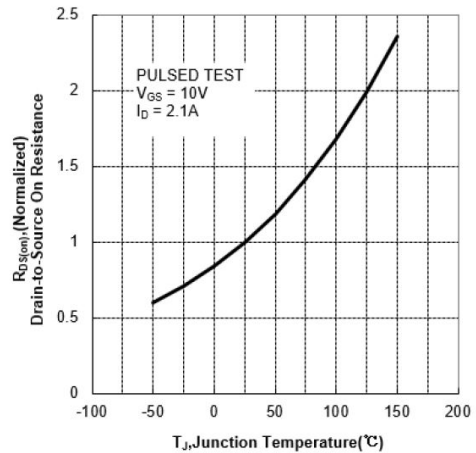


Fig11. Typical Threshold Voltage vs. Junction Temperature

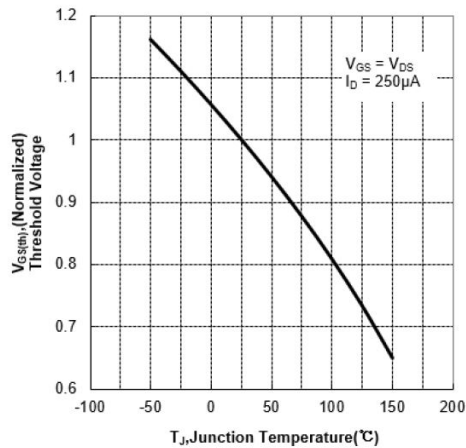


Fig12. Typical Breakdown Voltage vs. Junction Temperature

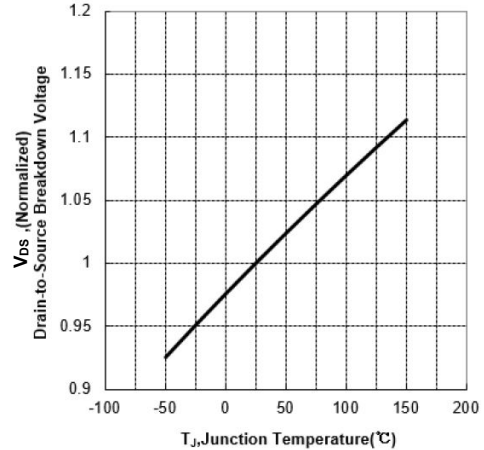




Fig 13. Typical Capacitance  
vs. Drain to Source Voltage

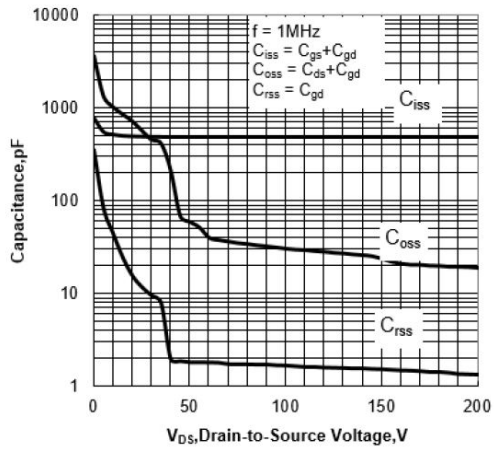
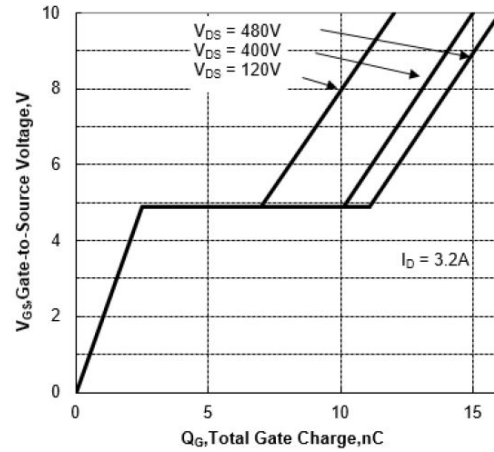


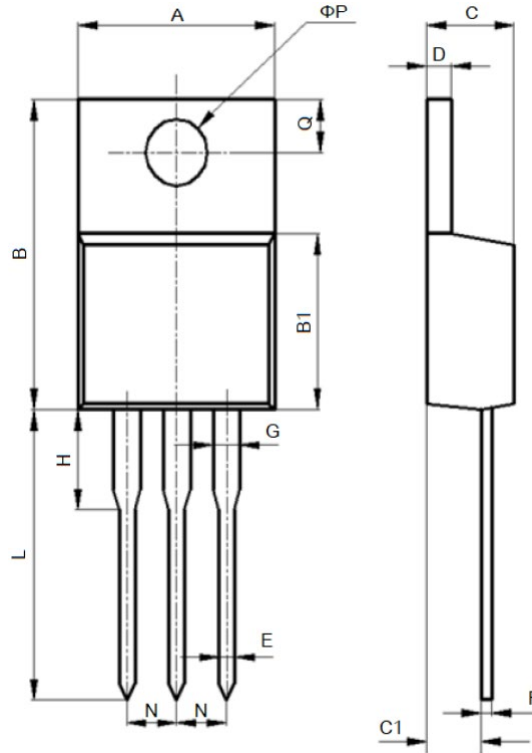
Fig 14. Typical Gate Charge  
vs. Gate to Source Voltage





**PACKAGE INFORMATION**

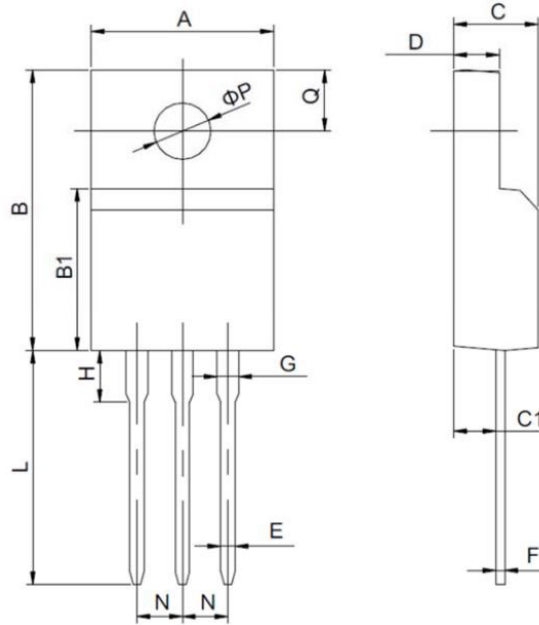
Dimension in TO-220 (Unit: mm)



Symbol	Min.	Max.
A	9.600	10.600
B	15.000	16.000
B1	8.900	9.500
C	4.300	4.800
C1	2.300	3.100
D	1.200	1.400
E	0.700	0.900
F	0.300	0.600
G	1.170	1.370
H	2.700	3.800
L	12.600	14.800
N	2.340	2.740
Q	2.400	3.000
ΦP	3.500	3.900



Dimension in TO-220F (Unit: mm)

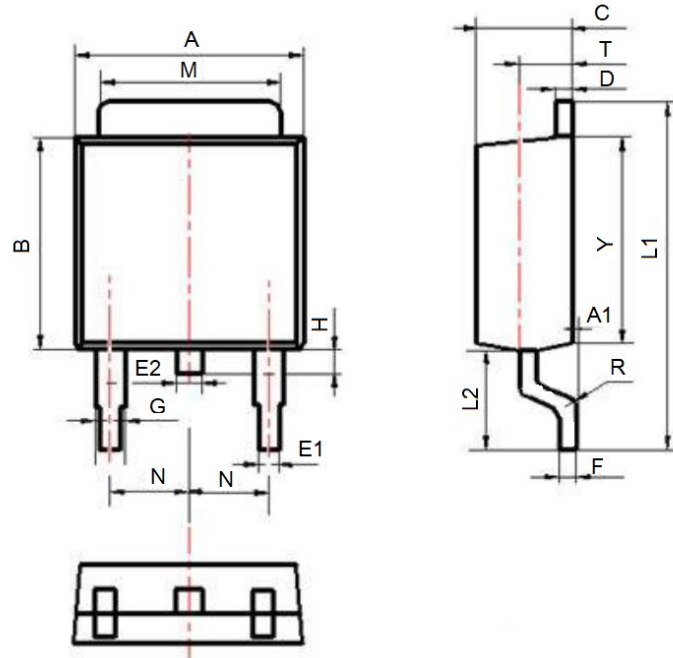


Symbol	Min.	Max.
A	9.600	10.400
B	15.400	16.200
B1	8.900	9.500
C	4.300	4.900
C1	2.100	3.000
D	2.400	3.000
E	0.600	1.000
F	0.300	0.600
G	1.120	1.420
H	1.600	3.800
L	12.000	14.000
N	2.340	2.740
Q	3.150	3.550
ΦP	2.900	3.300





Dimension in TO-252 (Unit: mm)



Symbol	MILLIMETERS	
	Min.	Max.
A	6.300	6.900
A1	0	0.130
B	5.700	6.300
C	2.100	2.500
D	0.300	0.600
E1	0.600	0.900
E2	0.700	1.000
F	0.300	0.600
G	0.700	1.200
L1	9.600	10.500
L2	2.700	3.100
H	0.600	1.000
M	5.100	5.500
N	2.090	2.490
R	0.300	
T	1.400	1.600
Y	5.100	6.300



## **IMPORTANT NOTICE**

AiT Semiconductor Inc. (AiT) reserves the right to make changes to any its product, specifications, to discontinue any integrated circuit product or service without notice, and advises its customers to obtain the latest version of relevant information to verify, before placing orders, that the information being relied on is current.

AiT Semiconductor Inc. integrated circuit products are not designed, intended, authorized, or warranted to be suitable for use in life support applications, devices or systems or other critical applications. Use of AiT products in such applications is understood to be fully at the risk of the customer. As used herein may involve potential risks of death, personal injury, or server property, or environmental damage. In order to minimize risks associated with the customer's applications, the customer should provide adequate design and operating safeguards.

AiT Semiconductor Inc. assumes to no liability to customer product design or application support. AiT warrants the performance of its products of the specifications applicable at the time of sale.